

Form PTO-1449 U.S. Department of Commerce  
(REV. 2-82) Patent and Trademark Office

Atty. Docket No.  
036115/US/2 - 475387-  
00016

Serial No.  
10/501,276

**INFORMATION DISCLOSURE STATEMENT  
BY APPLICANT**

(Use several sheets if necessary)

Applicant(s)  
Johannes F. de Boer et al.

Filing Date  
July 9, 2004

Confirmation No.  
3104

**U.S. PATENT DOCUMENTS**

*Exam. Init.		Document No.							Date	Name	Class	Subclass	Filing Date if Appropriate
	2004	0	1	0	0	6	8	1	May 2004	Bjarklev et al. <sup>Φ</sup>			
	2004	0	0	8	6	2	4	5	May 2004	Farroni et al. <sup>Φ</sup>			
	2002	0	1	7	2	4	8	5	November 2002	Keaton et al. <sup>Φ</sup>			
	2002	0	1	8	8	2	0	4	December 12, 2002	McNamara et al. <sup>ΦΦ</sup>			
	2002	0	0	7	6	1	5	2	June 20, 2002	Hughes et al. <sup>ΦΦΦ</sup>			
		6	7	9	0	1	7	5	September 14, 2004	Furusawa et al. <sup>ΦΦΦΦ</sup>			
		6	2	6	4	6	1	0	July 24, 2001	Zhu <sup>ΦΦΦΦΦ</sup>			
		6	0	1	4	2	1	4	January 11, 2000	Li <sup>ΦΦΦΦΦΦ</sup>			
		3	6	0	1	4	8	0	August 24, 1971	Donald Sexton Randall <sup>ΦΦΦΦΦΦΦ</sup>			
		5	4	1	1	0	1	6	May 2, 1995	Kume et al. <sup>€€</sup>			
		5	7	4	0	8	0	8	April 21, 1998	Panescu et al. <sup>€€</sup>			

**FOREIGN PATENT DOCUMENT**

		Document No.							Date	Country	Class	SubClass	<u>Translator</u> Yes No	
	2005	0	0	0	0	1	1	5	January 6, 2005	WIPO <sup>ΦΦ</sup>				
		9	8	0	1	0	7	4	January 15, 1998	WIPO <sup>ΦΦ</sup>				
	2004	0	0	6	6	8	2	4	August 12, 2004	WIPO <sup>ΦΦ</sup>				
	1	0	3	5	1	3	1	9	June 16, 2005	Germany <sup>ΦΦΦΦ</sup>				
		9	8	3	8	9	0	7	September 11, 1998	WIPO <sup>ΦΦΦΦ</sup>				
		1	2	5	7	7	7	8	December 22, 1971	Great Britain <sup>ΦΦΦΦΦΦΦ</sup>				

Examiner

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\* Examiner: Initial citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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	200	5	0	5	4	7	8	0	June 16, 2005	WIPO <sup>ΦΦΦΦΦΦΦΦ</sup>				
	200	6	1	3	0	7	9	7	December 7, 2006	WIPO <sup>ΦΦΦΦΦΦΦΦ</sup>				
	200	6	0	1	4	3	9	2	February 9, 2006	WIPO <sup>ΦΦΦΦΦΦΦΦ</sup>				
		9	8	4	6	1	2	3	October 22, 1998	WIPO €€				
		0	5	9	0	2	6	8	April 6, 1994	European €€				

<sup>Φ</sup> References cited in Office Action dated February 2, 2007 for U.S. Patent Application No. 11/174,425

<sup>ΦΦ</sup> References cited in International Search Report PCT/US2006/031905

<sup>ΦΦΦ</sup> References cited in Office Action dated March 28, 2007 for U.S. Patent Application No. 11/241,907

<sup>ΦΦΦΦ</sup> References cited in International Search Report PCT/US2007/060481

<sup>ΦΦΦΦΦ</sup> References cited in Office Action dated May 23, 2007 for U.S. Patent Application No. 10/406,751

<sup>ΦΦΦΦΦΦ</sup> References cited in Office Action dated May 23, 2007 for U.S. Patent Application No. 10/551,735

<sup>ΦΦΦΦΦΦΦ</sup> References cited in International Search Report PCT/US2007/060717

<sup>ΦΦΦΦΦΦΦΦ</sup> References cited in International Search Report PCT/US2007/060319

€€ References cited in European Patent Office Search Report for Application No. 01991092.6-2305

**OTHER DOCUMENTS (including Author, Title Date, Pertinent Pages, Etc.)**

			PCT International Search Report and Written Opinion for Application No. PCT/US2006/031905 dated May 3, 2007
			PCT International Search Report and Written Opinion for Application No. PCT/US2007/060481 dated May 23, 2007
			PCT International Search Report and Written Opinion for Application No. PCT/US2007/060717 dated May 24, 2007
			PCT International Search Report and Written Opinion for Application No. PCT/US2007/060319 dated June 6, 2007
			D. Yelin et al., "Three-dimensional imaging using spectral encoding heterodyne interferometry", Optics Letters, July 15, 2005, Vol. 30, No. 14, Pages 1794-1796 <sup>ΦΦΦΦΦΦΦΦ</sup>
			Copy of Office Action dated February 2, 2007 for U.S. Patent Application No. 11/174,425

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			European Patent Office Search report for Application No. 01991092.6-2305 dated January 12, 2006

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